


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,803	LEE ET AL.	
	Examiner	Art Unit	
	Linh V. Nguyen	2819	

SEARCHED			
Class	Subclass	Date	Examiner
330	9	10/2/2005	LN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
330/9,69,254; 341/143,172 (See search printout)	10/2/2005	LN